

FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-226-02	SERIAL NO.		
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				APPLICANT K. YANASE et al			
				FILING DATE 02/24/04	GROUP 2177		
U.S. PATENT DOCUMENTS							
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE <i>(If Appropriate)</i>
EE	AA	5,515,531	05/07/96	Fujiwara et al			
EE	AB	6,161,105	12/2000	Keighan et al			
EE	AC	6,003,036	12/1999	Martin			
EE	AD	5,983,215	11/1999	Ross et al			
EE	AE	6,421,612	07/2002	Agrafiotis et al			
EE	AF	5,761,652	06/1998	Wu et al			
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
<i>Not provided</i> X X X X		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AL	10-240744	09/11/98	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AM	10-269225	10/09/98	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AN	06-314299	11/08/94	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AO	06-139119	05/20/94	Japan			<input type="checkbox"/> <input type="checkbox"/>
	AP						<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
	AR						
	AS						
	AT						
EXAMINER <div style="text-align: center;">/Emeka Ebirim/</div>				DATE CONSIDERED 09/11/2006			
<small>* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							